Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/825,377	YOSHIDA ET AL.	
Examiner	Art Unit	
John Teresinski	2858	

	SEAR	CHED	
Class	Subclass	Date	Examiner

ראו	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARCH	TES I STRATEGY)	)
	DATE	EXMR
324/662,658,686 in east with text	11/25/2005	JΤ